**ON Semiconductor** 

Is Now

# Onsemi

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# **Power MOSFET**

-30 V, -9.6 A, P-Channel, SOIC-8

#### Features

- Low R<sub>DS(on</sub>) to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- SOIC-8 Surface Mount Package Saves Board Space
- This is a Pb-Free Device

#### Applications

- Load Switches
- Notebook PC's
- Desktop PC's

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

Rating			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	-30	V
Gate-to-Source Voltage			V <sub>GS</sub>	±25	V
Continuous Drain		T <sub>A</sub> = 25°C	۱ <sub>D</sub>	-7.3	А
Current $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 70°C		-5.8	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	1.44	W
Continuous Drain		T <sub>A</sub> = 25°C	Ι <sub>D</sub>	-5.5	А
Current $R_{\theta JA}$ (Note 2)	Steady	T <sub>A</sub> = 70°C		-4.4	
Power Dissipation $R_{\theta JA}$ (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.81	W
Continuous Drain		T <sub>A</sub> = 25°C	Ι <sub>D</sub>	-9.6	А
Current R <sub>θJA</sub> t < 10 s (Note 1)		T <sub>A</sub> = 70°C		-7.7	
Power Dissipation $R_{\theta JA} t < 10 s (Note 1)$		$T_A = 25^{\circ}C$	P <sub>D</sub>	2.5	W
Pulsed Drain Current		= 25°C, = 10 μs	I <sub>DM</sub>	-39	A
Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C	
Source Current (Body Diode)			۱ <sub>S</sub>	-2.1	А
Single Pulse Drain-to-Source Avalanche Energy T <sub>J</sub> = 25°C, V <sub>DD</sub> = 30 V, V <sub>GS</sub> = 10 V, I <sub>L</sub> = 15 A <sub>pk</sub> , L = 1.0 mH, R <sub>G</sub> = 25 $\Omega$		EAS	112.5	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 inch sq pad size, 1 oz Cu.

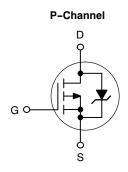
2. Surface-mounted on FR4 board using the minimum recommended pad size.



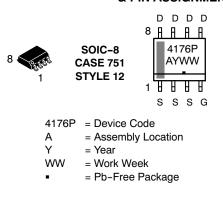
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#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Max	I <sub>D</sub> Max
-30 V	18 mΩ @ -10 V	-9.6 A
	30 mΩ @ -4.5 V	0.071



#### MARKING DIAGRAM & PIN ASSIGNMENT



#### **ORDERING INFORMATION**

[	Device	Package	Shipping <sup>†</sup>
	NTMS4176PR2G	SOIC-8 (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE RATINGS

Rating	Symbol	Мах	Unit
Junction-to-Ambient – Steady State (Note 3)	$R_{ hetaJA}$	87	
Junction-to-Ambient – t≤10 s (Note 3)	$R_{ hetaJA}$	50	°C/W
Junction-to-FOOT (Drain)	$R_{ hetaJF}$	22	-C/W
Junction-to-Ambient – Steady State (Note 4)	$R_{ ext{ heta}JA}$	154	

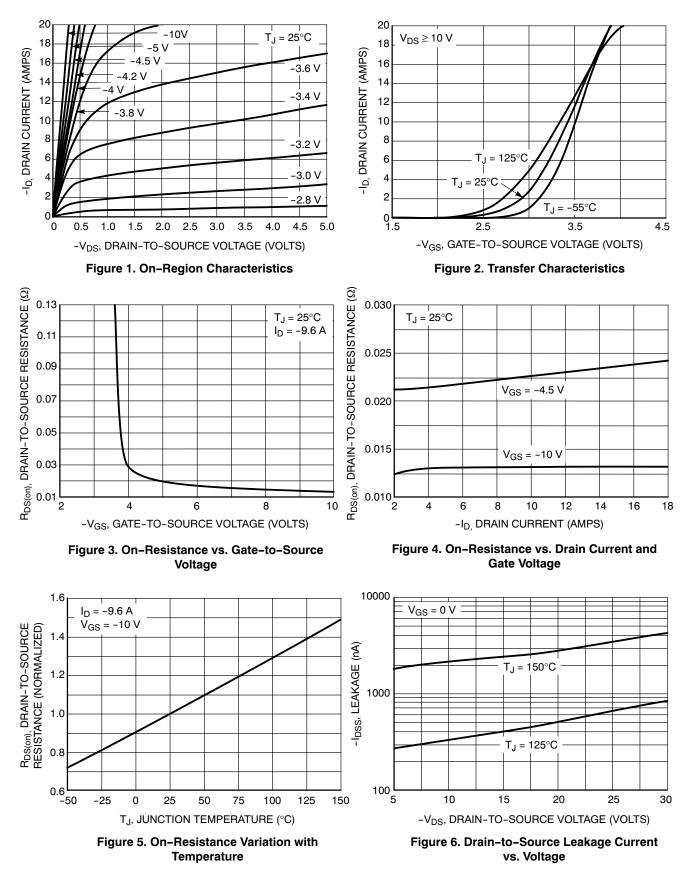
Surface-mounted on FR4 board using 1 inch sq pad size, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)jk

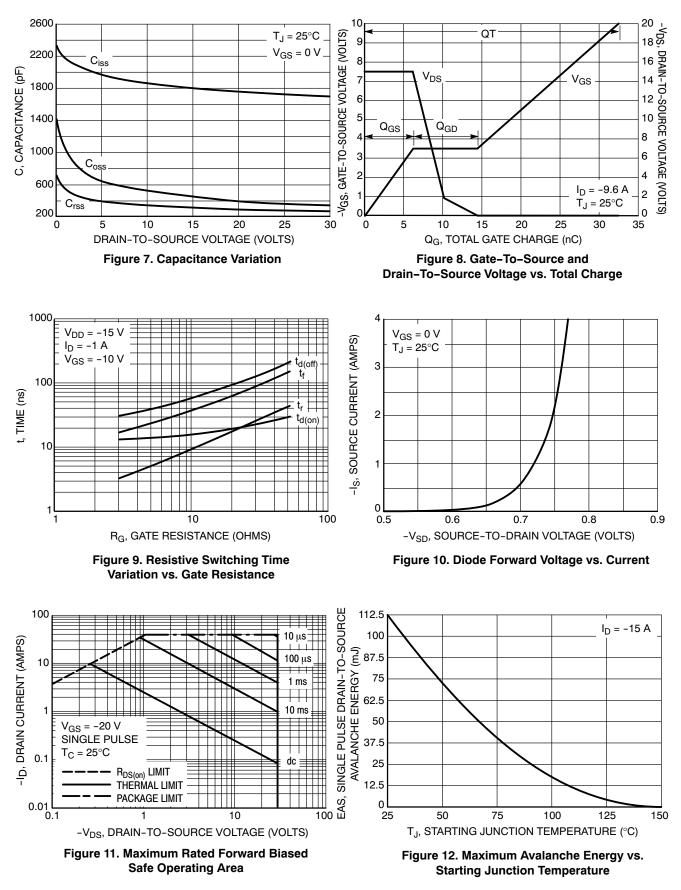
Characteristic	Symbol	Test Con	dition	Min	Тур	Max	Unit
OFF CHARACTERISTICS				•			
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D$	= -250 μA	-30			V
Drain-to-Source Breakdown Voltage Tem- perature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				29		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -24 V	T <sub>J</sub> = 25°C T <sub>J</sub> = 85°C			-1.0 -5.0	μA
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>G</sub>	-			±100	nA
ON CHARACTERISTICS (Note 5)	.033	103 - 1, 16					
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= -250 µA	-1.5		-2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>		µ		6.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10 V	I <sub>D</sub> = -9.6 A		14	18	
		V <sub>GS</sub> = -4.5 V	I <sub>D</sub> = -7.5 A		23	30	mΩ
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = -1.5 V,	l <sub>D</sub> = -9.6 A		21.5		S
CHARGES, CAPACITANCES AND GATE F	ESISTANCE			•			
Input Capacitance	C <sub>ISS</sub>	$V_{GS}$ = 0 V, f = 1.0 MHz, $V_{DS}$ = -24 V			1720		pF
Output Capacitance	C <sub>OSS</sub>				370		
Reverse Transfer Capacitance	C <sub>RSS</sub>				256		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DS</sub> = -15 V, I <sub>D</sub> = -9.6 A			17		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				2.0		
Gate-to-Source Charge	Q <sub>GS</sub>				6.0		
Gate-to-Drain Charge	Q <sub>GD</sub>				8.4		]
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -10 \text{ V}, V_{DS} = -15 \text{ V},$ $I_D = -9.6 \text{ A},$			32.6		nC
Gate Resistance	R <sub>G</sub>				3.0	4.5	Ω
SWITCHING CHARACTERISTICS (Note 6)							
Turn-On Delay Time	t <sub>d(ON)</sub>				15		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -10 V, V <sub>DD</sub> = -15 V,			9.0		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	I <sub>D</sub> = -1.0 A, R	$G = 6.0 \Omega$		19.5		
Fall Time	t <sub>f</sub>				42.5		<u> </u>
DRAIN-TO-SOURCE CHARACTERISTICS	i						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V	$T_J = 25^{\circ}C$		-0.75	-1.0	V
		I <sub>D</sub> = -2.1 A	T <sub>J</sub> = 125°C		0.59		
Reverse Recovery Time	t <sub>RR</sub>				32.4		ns
Charge Time	Ta	$V_{GS} = 0 V, d_{IS}/d_{t}$	= 100 A/μs,		14		113
Discharge Time	Т <sub>b</sub>	$I_{\rm S} = -2.1  {\rm A}$			18.4		
Reverse Recovery Time	Q <sub>RR</sub>				23		nC

5. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

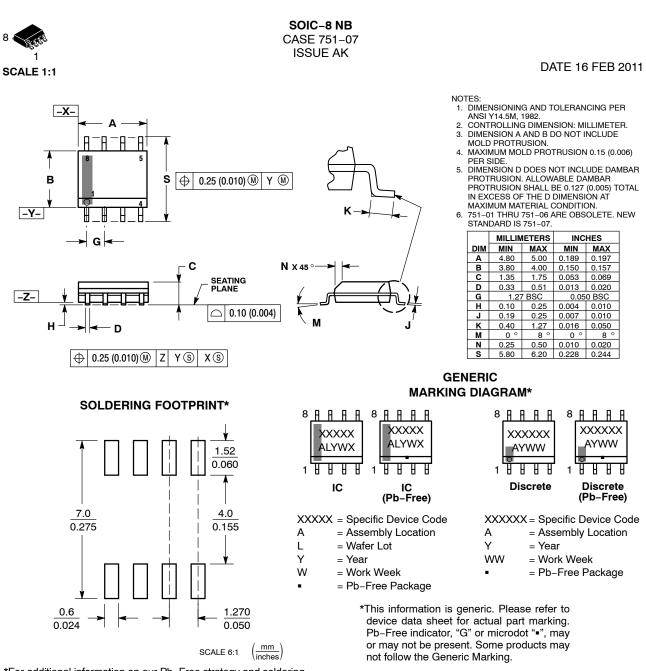
#### **TYPICAL PERFORMANCE CURVES**



#### **TYPICAL PERFORMANCE CURVES**







\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### STYLES ON PAGE 2

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#### SOIC-8 NB CASE 751-07 **ISSUE AK**

STYLE 1: PIN 1. EMITTER COLLECTOR 2. COLLECTOR 3. 4. EMITTER EMITTER 5. BASE 6. 7 BASE EMITTER 8. STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN DRAIN 4. GATE 5. 6. GATE SOURCE 7. 8. SOURCE STYLE 9: PIN 1. EMITTER, COMMON COLLECTOR, DIE #1 COLLECTOR, DIE #2 2. З. EMITTER, COMMON 4. 5. EMITTER, COMMON 6 BASE. DIE #2 BASE, DIE #1 7. 8. EMITTER, COMMON STYLE 13: PIN 1. N.C. 2. SOURCE 3 GATE 4. 5. DRAIN 6. DRAIN DRAIN 7. DRAIN 8. STYLE 17: PIN 1. VCC 2. V2OUT V10UT З. TXE 4. 5. RXE 6. VFF 7. GND 8. ACC STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3 CATHODE 3 CATHODE 4 4. 5. CATHODE 5 6. COMMON ANODE COMMON ANODE 7. 8. CATHODE 6 STYLE 25: PIN 1. VIN 2 N/C REXT З. 4. GND 5. IOUT 6. IOUT IOUT 7. 8. IOUT STYLE 29: BASE, DIE #1 PIN 1. 2 EMITTER, #1 BASE, #2 З. EMITTER, #2 4. 5 COLLECTOR, #2 COLLECTOR, #2 6.

STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 COLLECTOR, #2 3. 4 COLLECTOR, #2 BASE, #2 5. EMITTER, #2 6. 7 BASE #1 EMITTER, #1 8. STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN SOURCE 4. SOURCE 5. 6. GATE GATE 7. 8. SOURCE STYLE 10: GROUND PIN 1. BIAS 1 OUTPUT 2. З. GROUND 4. 5. GROUND 6. BIAS 2 INPUT 7. 8. GROUND STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3 P-SOURCE P-GATE 4. P-DRAIN 5 6. P-DRAIN N-DRAIN 7. N-DRAIN 8. STYLE 18: PIN 1. ANODE ANODE 2. SOURCE 3. GATE 4. 5. DRAIN 6 DRAIN CATHODE 7. CATHODE 8. STYLE 22: PIN 1. I/O LINE 1 2. COMMON CATHODE/VCC 3 COMMON CATHODE/VCC 4. I/O LINE 3 5. COMMON ANODE/GND 6. I/O LINE 4 7. I/O LINE 5 COMMON ANODE/GND 8. STYLE 26: PIN 1. GND 2 dv/dt З. ENABLE 4. ILIMIT 5. SOURCE SOURCE 6. SOURCE 7. 8. VCC STYLE 30: DRAIN 1 PIN 1. DRAIN 1 2 GATE 2 З. SOURCE 2 4. SOURCE 1/DRAIN 2 SOURCE 1/DRAIN 2 5.

6.

7.

8 GATE 1

SOURCE 1/DRAIN 2

STYLE 3: PIN 1. DRAIN, DIE #1 DRAIN, #1 2. DRAIN, #2 З. 4. DRAIN, #2 GATE, #2 5. SOURCE, #2 6. 7 GATE #1 8. SOURCE, #1 STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS THIRD STAGE SOURCE GROUND З. 4. 5. DRAIN 6. GATE 3 SECOND STAGE Vd 7. FIRST STAGE Vd 8. STYLE 11: PIN 1. SOURCE 1 GATE 1 SOURCE 2 2. З. GATE 2 4. 5. DRAIN 2 6. DRAIN 2 DRAIN 1 7. 8. DRAIN 1 STYLE 15: PIN 1. ANODE 1 2. ANODE 1 ANODE 1 3 ANODE 1 4. 5. CATHODE, COMMON CATHODE, COMMON CATHODE, COMMON 6. 7. CATHODE, COMMON 8. STYLE 19: PIN 1. SOURCE 1 GATE 1 SOURCE 2 2. 3. GATE 2 4. 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 8. **MIRROR 1** STYLE 23: PIN 1. LINE 1 IN COMMON ANODE/GND COMMON ANODE/GND 2. 3 LINE 2 IN 4. LINE 2 OUT 5. COMMON ANODE/GND COMMON ANODE/GND 6. 7. LINE 1 OUT 8. STYLE 27: PIN 1. ILIMIT OVI O 2 UVLO З. 4. INPUT+ 5. 6. SOURCE SOURCE SOURCE 7. 8 DRAIN

#### DATE 16 FEB 2011

STYLE 4: PIN 1. 2. ANODE ANODE ANODE З. 4. ANODE ANODE 5. 6. ANODE 7 ANODE COMMON CATHODE 8. STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE, #1 BASE #2 З. COLLECTOR, #2 4. COLLECTOR, #2 5. 6. EMITTER, #2 EMITTER, #1 7. 8. COLLECTOR, #1 STYLE 12: PIN 1. SOURCE SOURCE 2. 3. GATE 4. 5. DRAIN 6 DRAIN DRAIN 7. 8. DRAIN STYLE 16 EMITTER, DIE #1 PIN 1. 2. BASE, DIE #1 EMITTER, DIE #2 3 BASE, DIE #2 4. 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 COLLECTOR, DIE #1 7. COLLECTOR, DIE #1 8. STYLE 20: PIN 1. SOURCE (N) GATE (N) SOURCE (P) 2. 3. 4. GATE (P) 5. DRAIN 6. DRAIN DRAIN 7. 8. DRAIN STYLE 24: PIN 1. BASE EMITTER 2. 3 COLLECTOR/ANODE COLLECTOR/ANODE 4. 5. CATHODE 6. CATHODE COLLECTOR/ANODE 7. 8. COLLECTOR/ANODE STYLE 28: PIN 1. SW\_TO\_GND 2. DASIC OFF DASIC\_SW\_DET З. 4. GND 5. 6. V MON VBULK 7. VBULK 8 VIN

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COLLECTOR, #1

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